

<b>Notice of References Cited</b>	Application/Control No. 10/652,000		Applicant(s)/Patent Under Reexamination INABA ET AL.	
	Examiner Srirama Channavajjala		Art Unit 2166	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,704,905	03-2004	Fukushige et al.	715/500
*	B	US-6,415,282	07-2002	Mukherjea et al.	707/3
*	C	US-6,189,002	02-2001	Roitblat, Herbert L.	707/1
*	D	US-6,829,619	12-2004	Wakamatsu et al.	707/104.1
*	E	US-6,922,699	07-2005	Schuetze et al.	707/103R
*	F	US-6,990,494	01-2006	Bates et al.	707/10
*	G	US-2002/0042793	04-2002	Choi, Jun-Hyeog	707/6
*	H	US-2004/0117388	06-2004	Inaba et al.	707/100
*	I	US-2002/0029232	03-2002	BOBROW et al.	707/517
*	J	US-2001/0037324	11-2001	Agrawal et al.	707/1
*	K	US-2002/0152051	10-2002	Fukushige et al.	702/179
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 1376408	01-2004	European	Uchiyama, Tadasu et al.	17/30
	O	WO2005/109251	11-2005	PCT	Wu, Zhe	17/30
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	Ogawa Yasushi et al. "a new character-based indexing method using frequency data for japanese documents", annual ACM conference on research and development in information retrieval 1995, pp 121-129			
	V	Venkat N Gudivada et al. "information retrieval on the world wide web", IEEE internet computing, 1997, pp 58-68			
	W	Oktay Ibrahimov et al. "clustering of imperfect transcripts using a novel similarity measure", conference information: information retrieval techniques for speech applications, sept 2001, pp 23-28			
	X	Eui-Kyu Park et al. "web document retrieval using sentence-query similarity", Conference: the eleventh text retrieval conference, TREC 2002, pyb.date: 2003, pp 835-841			

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.